

Advances in sCVD Diamond Detectors: Quality Control, Energy Resolution, and Statistical Fluctuations

EuPRAXIA-DN Camp I: Technologies

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Diamond Detectors

Chemical vapor deposition (CVD) Diamond

- $e_{gap} = 5.47 \text{ eV}$
- $E_{ion} = 13.1 \text{ eV}$

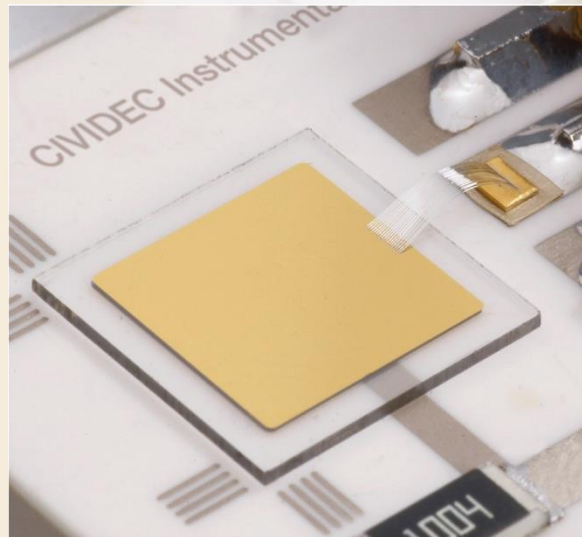
- ✓ Radiation hard semiconductor
- ✓ Temperature insensitive (up to 500 K)
- ✓ Low dark current (pA)
- ✓ Intrinsically low noise
- ✓ Fast response (ns charge collection)
- ✓ Expensive

Development Process

Crystal*



Sensor*



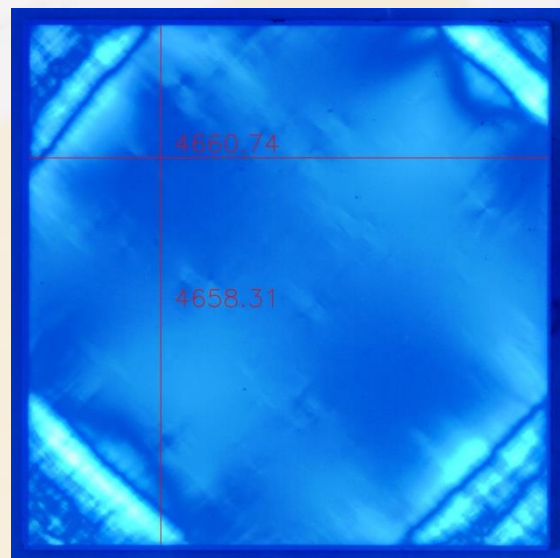
Detector*



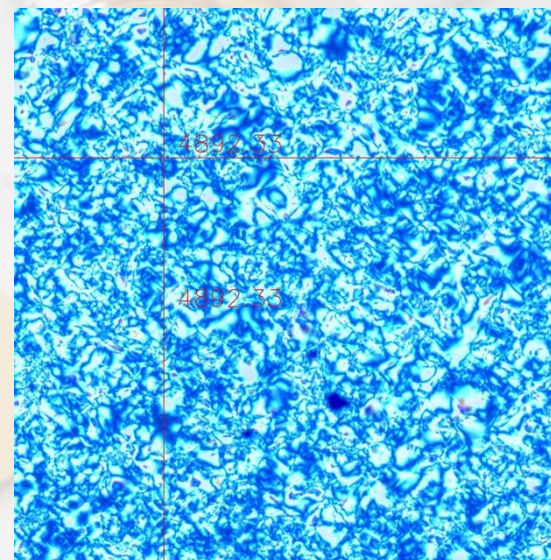
* CIVIDEC: <https://cividec.at/>

* Element6: <https://www.e6.com/>

Quality Control - I



sCVD

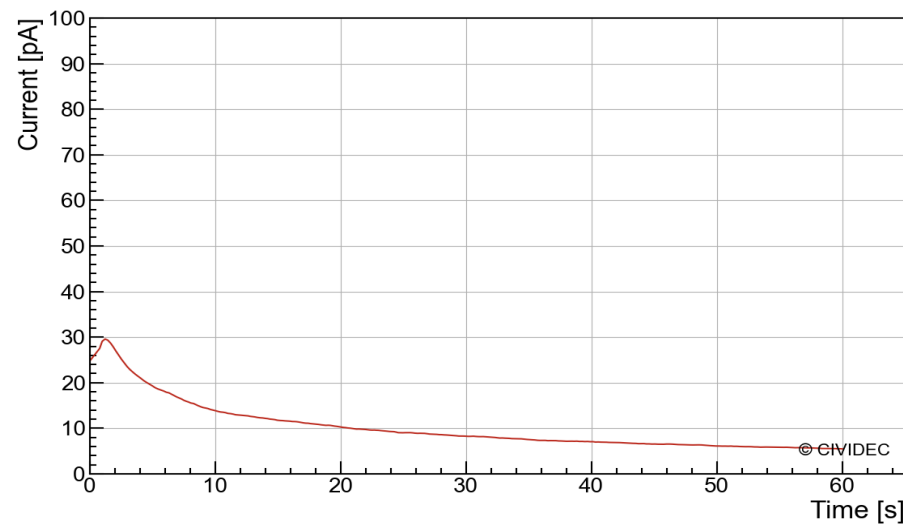


pCVD

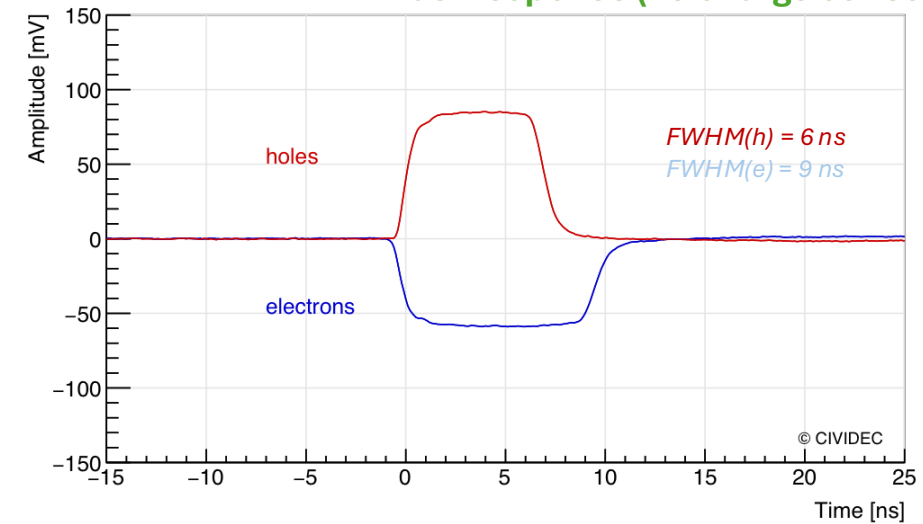
Crystal Quality : Cross Polarized visible light microscopy

Quality Control - II

Low dark current (~ 10 pA)



Fast response (ns charge collection)

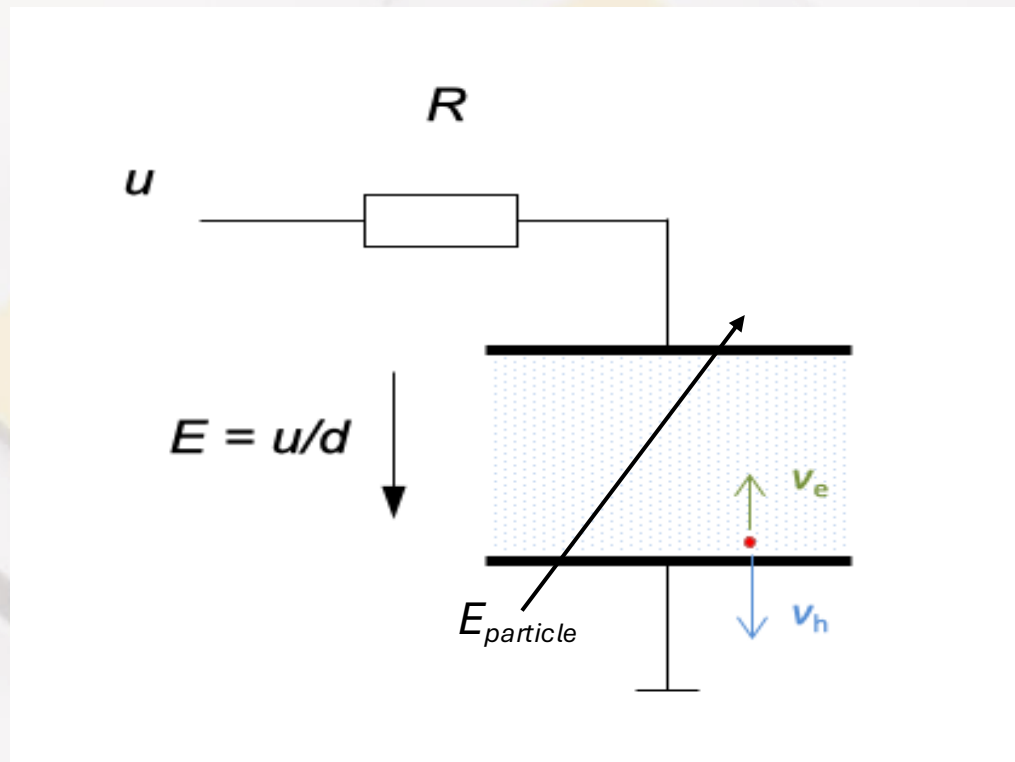


Sensor Quality: It and TCT profile after metallization.

Performance:Energy resolution

High-precision alpha spectroscopy

Ionization in Diamond Detectors

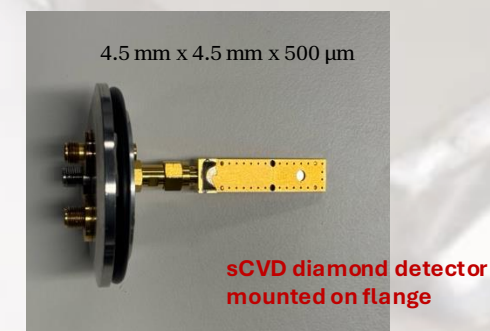
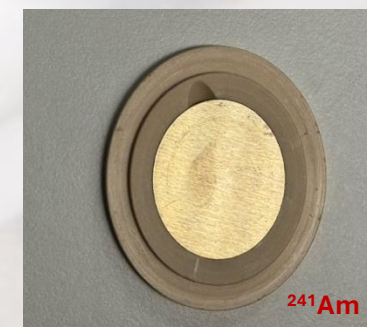
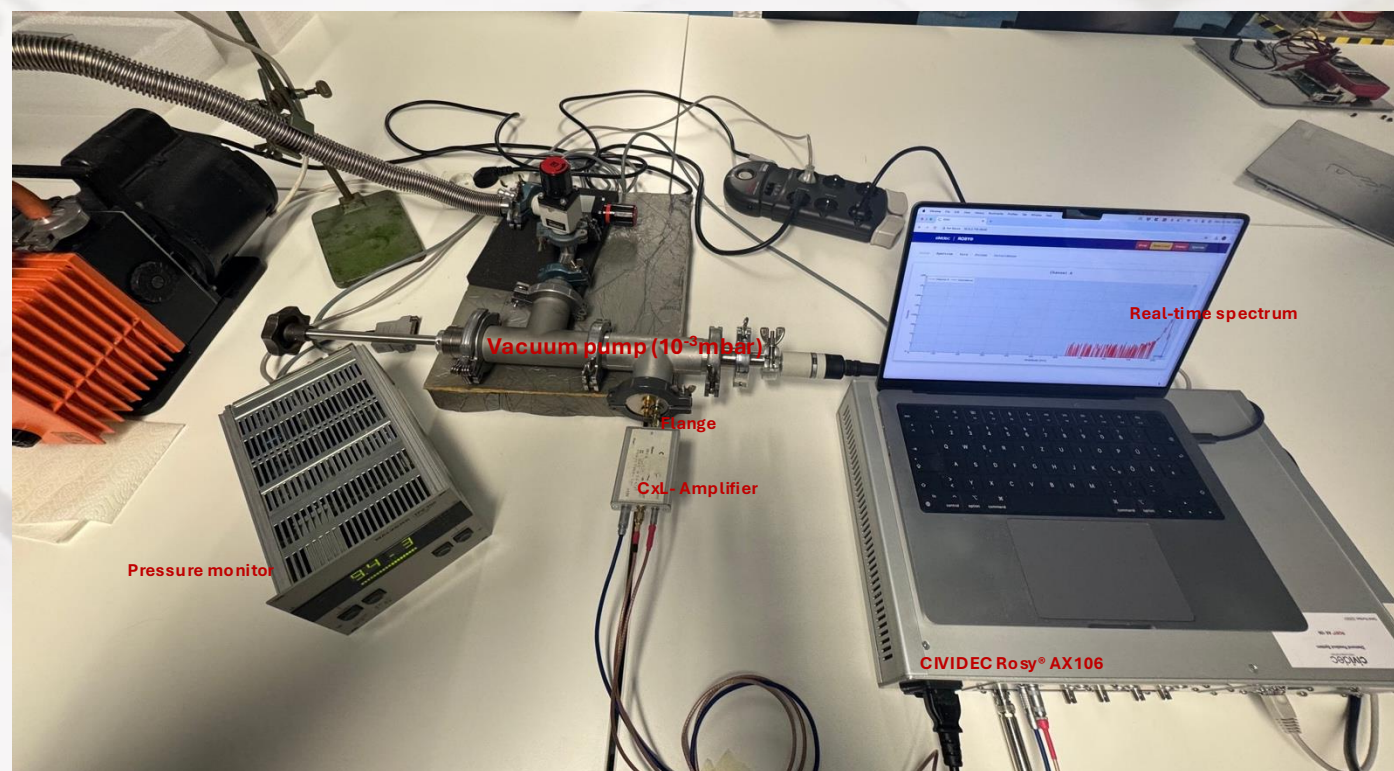


Courtesy: Dr. Christina Weiss

$$N_e + N_h = E_{ion}/E_{particle}$$

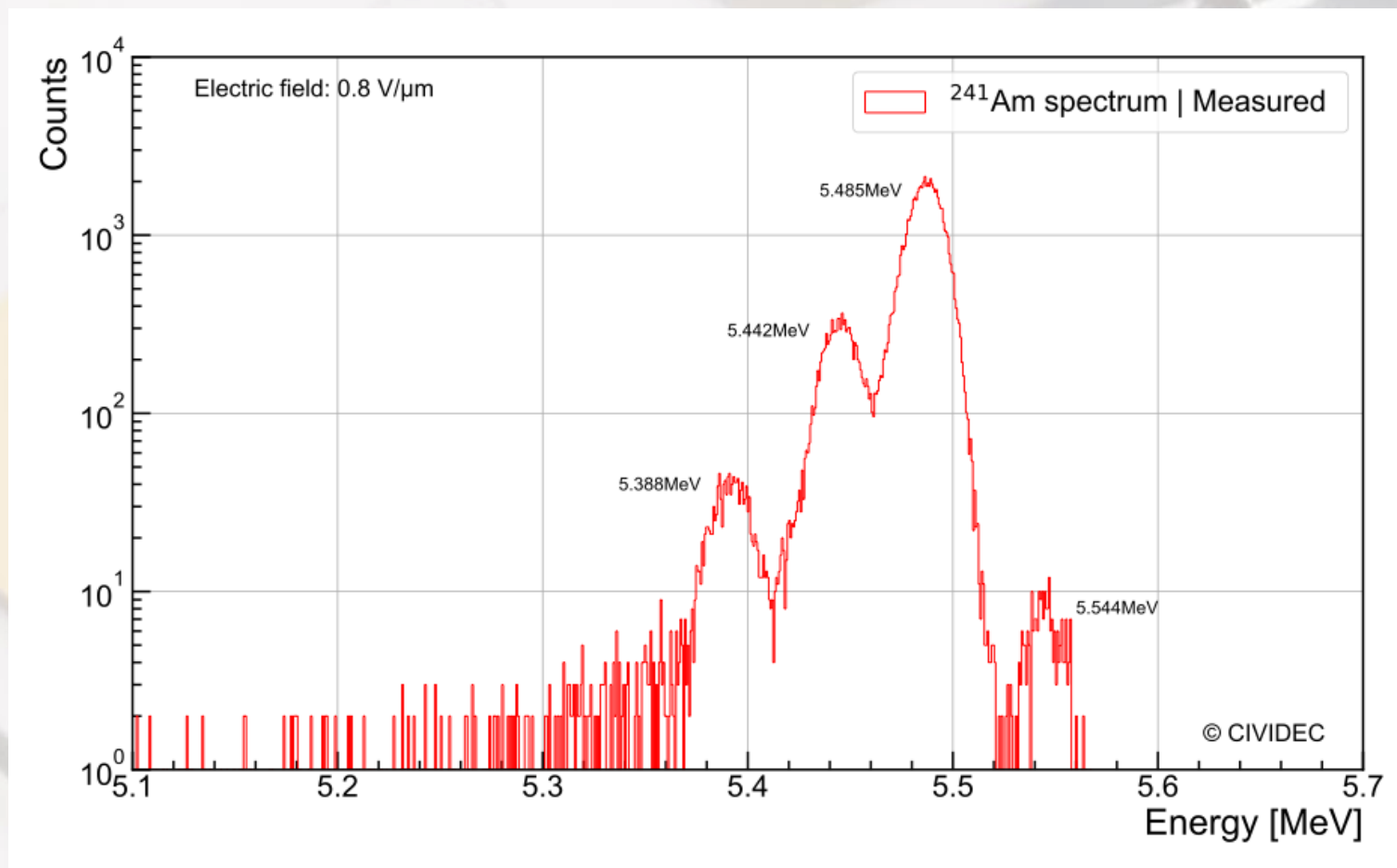
$$Q_{ion} = (N_e + N_h) \cdot e$$

Experiment Setup



Experimental setup at Atomic Institute, TU Wien

Measured Spectrum



Response of sCVD diamond detector to the α -particles of ^{241}Am .

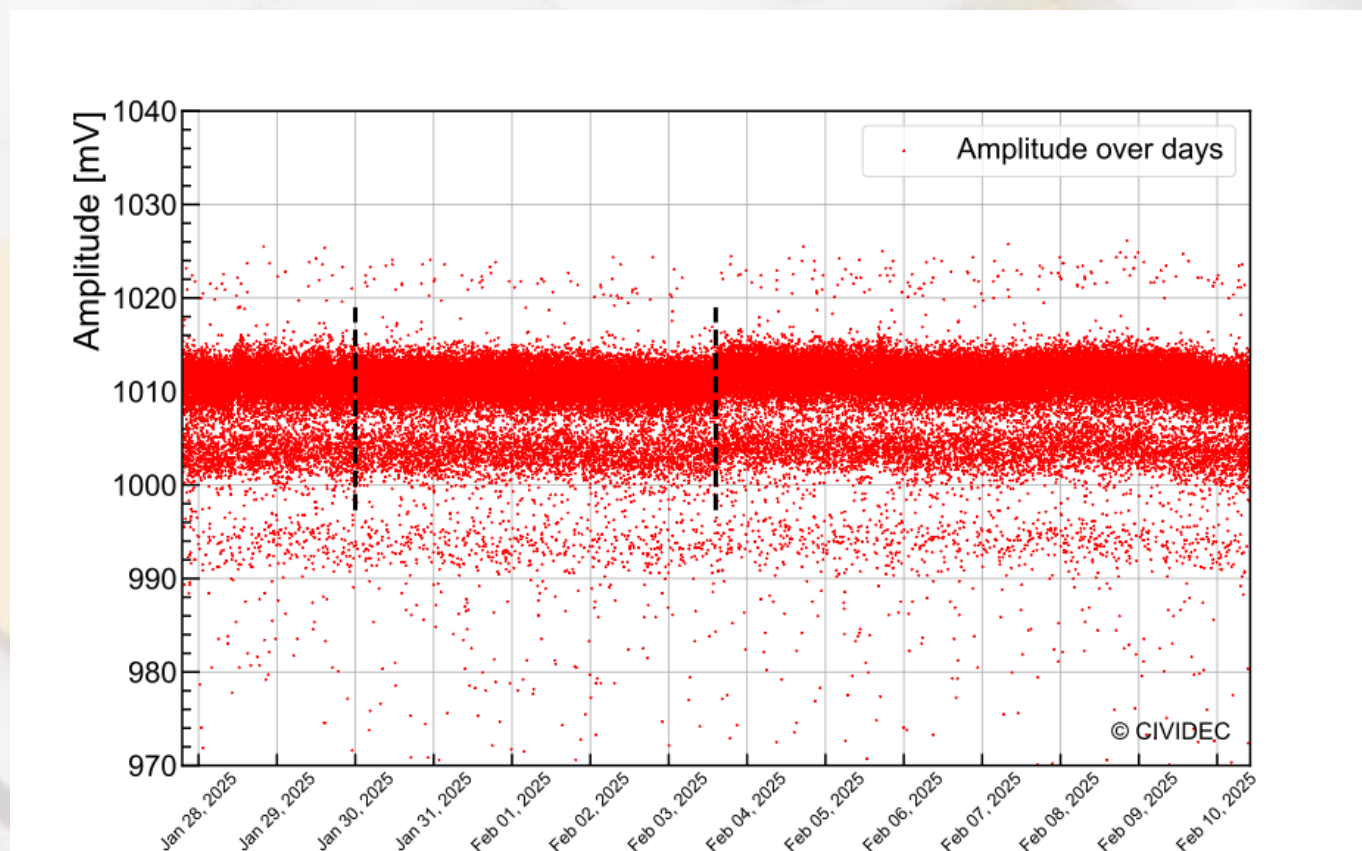
Factor Impacting the Energy Resolution

Factor	Methodology	Sigma [keV]
Source (10 nm)	via Geant4 simulation	1.21
Air	Vacuum	NaN
Electrode (100 nm Ti)	via Geant4 simulation	3.73
Electronic noise	Electronic calibration at CIVIDEC	5.69
Statistical Fluctuations	Theoretically/Literature	2.39

$$\sigma^2 = \sigma_{\text{stat}}^2 + \sigma_{\text{electronic}}^2 + \sigma_{\text{electrode}}^2 + \sigma_{\text{source}}^2$$

$$\sigma = 7.31 \text{ KeV}$$

Environmental conditions



The pulse amplitude as a function of time is shown.

Results

Results	Method	FWHM [keV]
Experiment [*]	No peak fitting or offline analysis	<u>16.68</u>
Pomoski ¹	Gaussian fitting	17
Shimaoka ²	Gaussian fitting	16.7

^{*}the FWHM is derived from the stable amplitude time window of data recorded.

¹ <https://doi.org/10.1002/pssa.200671127>

² <https://doi.org/10.1002/pssa.201600195>

Statistical Fluctuations

$$\sigma_{\text{experimental}}^2 = \sigma_{\text{source}}^2 + \sigma_{\text{electrode}}^2 + \sigma_{\text{stat}}^2 + \sigma_{\text{electronic}}^2$$

$$\sigma_{\text{stat}} (\text{Poisson distribution}) = \sqrt{N}$$

$$\sigma_{\text{stat}} (\text{Detector}) = \sqrt{F} \cdot \sqrt{N}$$

$$N \text{ (total number in e-h pairs)} = \frac{E_{\text{particle}}}{E_{\text{ion}}}$$

F = Fano Factor

E_{particle} = Deposited energy

E_{ion} = Ionization energy

$$*F_{\text{literature}} = 0.08$$

$$*F_{\text{experiment}} = 0.03$$

*R. C. Alig, S. Bloom, and C. W. Struck, Phys. Rev. B 22, 5565 (1980).

*the accuracy of the Fano Factor evaluation is primarily dependent on the precision of other measurement factors mentioned in the above equation.

Thank you for your attention !

www.cividec.at